

Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)			ATTY. DKT. NO. 5760-18900 APPLICANT: Ranade, et al. FILING DATE: December 31, 2003		SERIAL NO. 10/749,267 GROUP: 2141		
U.S. PATENT DOCUMENTS							
EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
/LL/		B7		A. Rowstron and P. Druschel. "Pastry: Scalable, distributed object location and routing for large-scale peer-to-peer systems." In Proc. <i>IFIP/ACM Middleware 2001</i> , Heidelberg, Germany, Nov. 2001.			
		B8		Zhao, et al "Tapestry: An Infrastructure for Fault-tolerant Wide-area Location and Routing" <i>UCB Tech. Report UCB/CSD-01-1141</i> . April 2001.			
		B9		Stoica, et al "Chord: A Scalable Peer-to-peer Lookup Service for Internet Applications," <i>ACMSIGCOMM 2001</i> , San Diego, CA, August 2001, pp. 149-160.			
		B10		Manku, et al, "Symphony: Distributed Hashing in a Small World" Published in USITS, 2003.			
		B11		Kubiatowicz, et al "OceanStore: An Architecture for Global-scale Persistent Storage" <i>Proceedings of ACM ASPLOS</i> , November 2000.			
		B12		Adya, et al; "FARSITE: Federated, Available, and Reliable Storage for an Incompletely Trusted Environment"; <i>Proceedings of the 5TH OSDI</i> , December 2002.			
		B13		Garces-Erice, et al; "Hierarchical Peer-to-Peer Systems," In the Special issue of the <i>Parallel Processing Letters</i> (PPL), December 2003, Vol.13, No. 4.			
		B14		"Lustre Whitepaper Version 1.0" Cluster File Systems, Inc., Nov. 11, 2002.			
		B15		"Sun StorEdge™ QFS and SAM-FS Software Technical Overview," Sun Microsystems, March 2004			
↓		B16		"Large Scale Peer-to-Peer Experiments with Virtual Private Community (VPC) Framework," Iwao, et al., CIA 2002, LNAI 2446, pp. 66-81, 2002.			
/LL/		B17		"BestPeer: A Self-Configurable Peer-to-Peer System," Ng, et al, Department of Computer Science, National University of Singapore, pp. 1-21.			

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DATE CONSIDERED: 01/09/2008

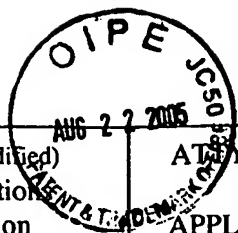
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U.S. PATENT DOCUMENTS

Information Disclosure Statement--PTO 1449 (modified)



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U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/LL/	B1	5,689,706	November 18, 1997	Rao, et al.			
	B2	6,782,389	August 24, 2004	Chrin, et al.			
	B3	6,173,293	January 9, 2001	Thekkath, et al.			
	B4	6,839,769	January 4, 2005	Needham, et al.			
	B5	6,625,604	September 23, 2003	Muntz, et al.			
	B6	5,832,512	November 3, 1998	Mastors, et al.			
	B7	6,748,381	June 8, 2004	Chao, et al.			
	B8	6,839,769	January 4, 2005	Needham, et al.			
	B9	2002/0114341	August 22, 2002	Andrew Sutherland			
↓	B10	2002/0147815	October 10, 2002	Alexander Tormasov			
/LL/	B12	2002/0065919	May 30, 2002	Ian Taylor			

FOREIGN PATENT DOCUMENTS

EXAM. INITIALS	REF. DES.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO

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